

2N4123

NPN EPITAXIAL SILICON TRANSISTOR

T-29-21

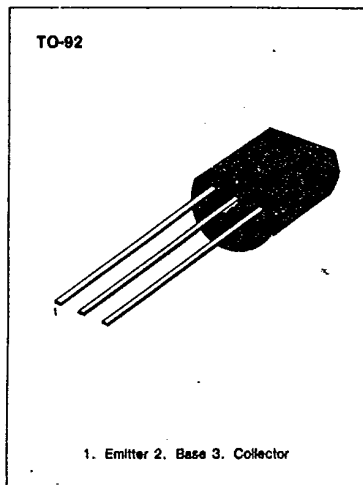
GENERAL PURPOSE TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 30V$
- Collector Dissipation: $P_C (\text{max}) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

* Refer to 2N3904 for graphs



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ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu A, I_E = 0$	40			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1mA, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$			50	nA
*DC Current Gain	h_{FE}	$I_C = 2mA, V_{CE} = 1V$	50		150	
		$I_C = 50mA, V_{CE} = 1V$	25			
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 50mA, I_B = 5mA$			0.3	V
*Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 50mA, I_B = 5mA$			0.95	V
Current Gain Bandwidth Product	f_T	$I_C = 10mA, V_{CE} = 20V$	250			MHz
		$f = 100MHz$				
Output Capacitance	C_{ob}	$V_{CB} = 5V, I_E = 0$			4	pF
		$f = 1MHz$				
Collector-Base Capacitance	C_{cb}	$V_{CB} = 5V, I_E = 0$			4	pF
		$f = 100KHz$				

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$